

Data sheet acquired from Harris Semiconductor SCHS030D – Revised December 2003

# CMOS Ripple-Carry Binary Counter/Dividers

High-Voltage Types (20-Volt Rating)

CD4020B — 14 Stage CD4024B — 7 Stage CD4040B — 12 Stage

■ CD4020B, CD4024B, and CD4040B are ripple-carry binary counters. All counter stages are master-slave flip-flops. The state of a counter advances one count on the negative transition of each input pulse; a high level on the RESET line resets the counter to its all zeros state. Schmitt trigger action on the input-pulse line permits unlimited rise and fall times. All inputs and outputs are buffered.

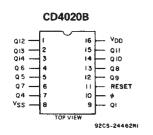
The CD4020B and CD4040B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes). The CD4040B type also is supplied in 16-lead small-outline packages (M and M96 suffixes).

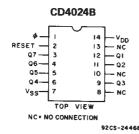
The CD4024B types are supplied in 14-lead hermetic dual-in-line ceramic packages (F3A suffix), 14-lead dual-in-line plastic packages (E suffix), 14-lead small-outline packages (M, MT, M96, and NSR suffixes), and 14-lead thin shrink small-outline packages (PW and PWR suffixes).

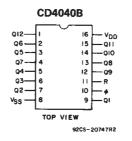
MAXIMUM RATINGS, Absolute-Maximum Values: DC SUPPLY-VOLTAGE RANGE, (VDD)

0.5V to +20V	Voltages referenced to V <sub>SS</sub> Terminal)
-0.5V to V <sub>DD</sub> +0.5V	INPUT VOLTAGE RANGE, ALL INPUTS
±10mA	DC INPUT CURRENT, ANY ONE INPUT
(P <sub>D</sub> ):	POWER DISSIPATION PER PACKAGE
500mW	For TA = -55°C to +100°C
Derate Linearity at 12mW/°C to 200mW	
RANSISTOR	DEVICE DISSIPATION PER OUTPUT T
ATURE RANGE (All Package Types)	FOR TA = FULL PACKAGE-TEMPER
T <sub>A</sub> )55°C to +125°C	OPERATING-TEMPERATURE RANGE
tg)65°C to +150°C	STORAGE TEMPERATURE RANGE (Ts
	LEAD TEMPERATURE (DURING SOLD
0.79mm) from case for 10s max +265°C	At distance 1/16 ± 1/32 inch (1.59 ± 0

#### **TERMINAL ASSIGNMENTS**







# CD4020B, CD4024B, CD4040B Types

#### Features:

- Medium-speed operation
- Fully static operation
- Buffered inputs and outputs
- 100% tested for quiescent current at 20 V
- Standardized, symmetrical output characteristics
- Fully static operation
- Common reset
- 5-V, 10-V, and 15-V parametric ratings
- Maximum input current of 1 μA at 18 V over full package-temperature range;
   100 nA at 18 V and 25°C
- Noise margin (over full package-tempera-

ture range): 1 V at  $V_{DD}$  = 5 V 2 V at  $V_{DD}$  = 10 V 2.5 V at  $V_{DD}$  = 15 V

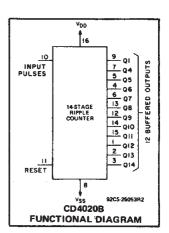
 Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

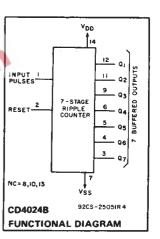
#### Applications:

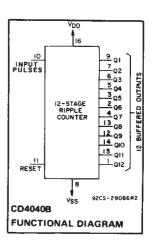
**■** Control counters

**■** Timers

- Frequency dividers
- Time-delay circuits







#### CD4020B, CD4024B, CD4040B Types

# RECOMMENDED OPERATING CONDITIONS at T<sub>A</sub> = 25°C, Unless Otherwise Specified

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC		V <sub>DD</sub>	Min.	Max.	UNITS
Supply Voltage Range (at T <sub>A</sub> = Ful Temperature Range)		3	18	v	
Input-Pulse Frequency,	fφ	5 10 15	- - -	3.5 8 12	MHz
Input-Pulse Width,	t <sub>W</sub>	5 10 15	140 60 40	<del>-</del>	ns
Input-Pulse Rise or Fall Time,	<sup>t</sup> rφ, <sup>t</sup> fφ	5 10 15	Unlim	nited	μs
Reset Pulse Width,	t₩	5 10 15	200 80 60	_	ns
Reset Removal Time,	<sup>t</sup> REM	5 10 15	350 150 100	-	ns 🐉

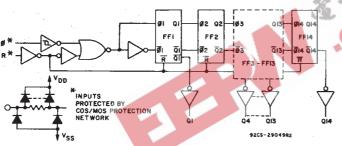
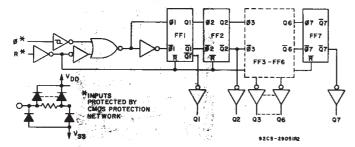


Fig. 1 - Logic diagram for CD4020B.



ig. 2 — Logic diagram for CD4024B.

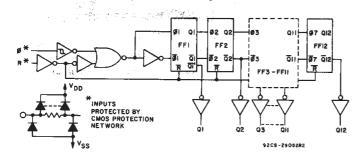


Fig. 3 - Logic diagram for CD4040B.

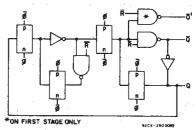


Fig. 4 - Detail of typical flip-flop stage.

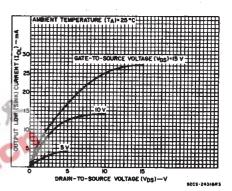
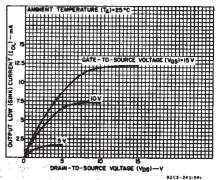
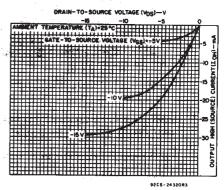


Fig. 5 - Typical output low (sink) current characteristics.



- Minimum output low (sink) current



- Typical output high (source) current characteristics.

# CD4020B, CD4024B, CD4040B Types

## STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	CONE	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)								
ISTIC	Vo	Vo	Vo	VIN	VDD						+25		UNITS
	(V)	(V)	(V)	-55	-40	+85	+125	Min.	Тур.	Max.			
Quiescent Device	_	0,5	5	5	5	150	150	-	0.04	5			
Current,		0,10	10	10	10	300	300	_	0.04	10			
IDD Max.	-	0,15	15	20	20	600	600	-	0.04	20	μА		
	-	0,20	20	100	100	3000	3000	-	0.08	100	1		
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1.	-			
(Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	<u> </u>	1		
IOL Min.	1.5	0,15	15.	4.2	4	2.8	2.4	34	6.8	-			
Output High	4.6	0,5	. 5	-0.64	-0.61	-0.42	-0.36	-0.51	1_	-	mA		
(Source)	2.5	0,5	. 5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	-	1 "		
Current, IOH Min.	9.5	0,10	10	-1.6	-1:5	-1.1	-0.9	-1.3	-2.6	_	1		
IOH WIII.	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	-	1		
Output Voltage:		0,5	5		0	.05		-	0	0.05			
Low-Level, VOL Max.	_	0,10	10		0	.05		_	0	0.05	-		
AOL Max.	-	0,15	15	0.05				_	0	0.05	31.3		
Output Voltage:	_	0,5	5		4	.95		4.95	5	-3	32		
High-Level,	-	0,10	10		9	.95		9.95	10	3-1	J		
VOH Min.		0,15	15	Y-	14	1.95		14.95	15	100	400		
Input Low	0.5, 4.5	-	5		1	1,5		-	_	1.5	10.		
Voltage,	1, 9	7 -	10			3	A 1	7	\ -	3			
VIL Max.	1.5,13.5	_	15	4			<u> </u>	\ — Y	4				
Input High	0.5, 4.5		5		3	3.5	) }	3.5	_		٧		
Voltage,	1, 9	-	10	7				7	-	_			
VIH Min.	1.5,13.5		15			11		11	<u> </u>	_			
Input Current IJN Max.	_	0,18	18	±0.1	±0.1	±1	±1	-	±10-5	±0.1	μΑ		

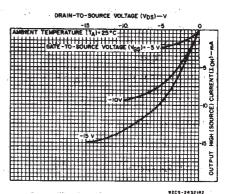


Fig. 8 – Minimum output high (source) current characteristics.

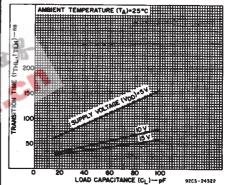
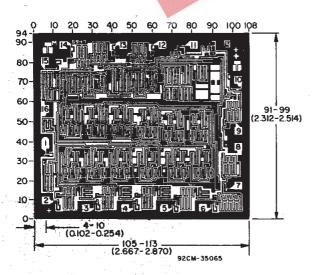
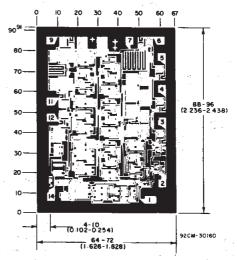


Fig. 9 — Typical transition time as a function of load capacitance.



Dimensions and Pad Layout for CD40208H. Dimensions and pad layout for CD40408H are identical.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10<sup>-3</sup> inch).



Dimensions and Pad Layout for CD4024BH.

### CD4020B, CD4024B, CD4040B Types

# DYNAMIC ELECTRICAL CHARACTERISTICS at T $_A$ = 25°C, Input t $_r$ , t $_f$ = 20 ns, C $_L$ = 50 pF, R $_L$ = 200 k $\Omega$

				LIMITS		
CHARACTERISTIC	TEST CONDITIONS	V <sub>DD</sub> (V)	Min.	Тур.	Max.	UNITS
Input-Pulse Operation					·	
Propagation Delay Time, $\phi$ to		5		180	360	
Q <sub>1</sub> Out; tpHL, tpLH		10	. <del>-</del> '	80	160	ns
- 1116-1-611		15	-	65	130	
0 40 0 44		5		100	330	
Q <sub>n</sub> to Q <sub>n</sub> + 1; <sup>t</sup> PHL <sup>, t</sup> PLH		10		40	80	ns
		15	_	30	60	
Transition Time,		5		100	200	
tTHL, tTLH		10	-	50	100	ns
111127 1 211		15	-	40	80	
Minimum Input-Pulse Width, t <sub>W</sub>		5	_	70	140	
		10	-	30	60	ns "
		15.	_	20	40	- Te 3
		5		-	40	7 13
Input-Pulse Rise or Fall		10	ι	Jnlimited	μs	
Time, $t_{r\phi}$ , $t_{f\phi}$		15			COL	
Maximum Input-Pulse		5	3.5	7	- *	
Frequency, f <sub>ø</sub>		10	8	16		MHz
ψ		15	12	24	_	1
Input Capacitance, C <sub>1</sub>	Any Input		_	5	7.5	рF
Reset Operation		M				
Propagation Delay		5	_	140	280	
Time, tpHL		10	_	60	120	ns
** *FNL		15		50	100	1
Minimum Reset Pulse		5		100	200	
Width, t <sub>W</sub>		10	-	40	80	ns
		15		30	60	<u> </u>
Reset Removal Time.		5	_	175	350	
tREM		10	_	75	150	ns
- NEIWI		15	-	50	100	

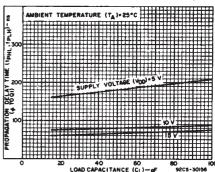


Fig. 10 — Typical propagation delay time as a function of load capacitance ( $\phi$  to  $Q_1$ ).

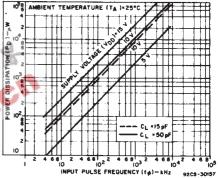


Fig. 11 — Typical dynamic power dissipation as a function of input pulse frequency for CD4020B.

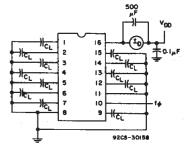


Fig. 12 – Dynamic power dissipation test circuit for CD4020B.

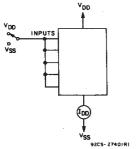


Fig. 13 — Quiescent device current test circuit.

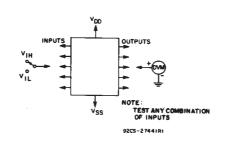


Fig. 14 - Input voltage test circuits.

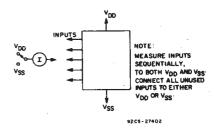


Fig. 15 - Input current test circuit.





28-Feb-2005

## **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
89271AKB3T	OBSOLETE	CFP	WR	16		None	Call TI	Call TI
89274AKB3T	OBSOLETE	CFP	WR	16		None	Call TI	Call TI
CD4020BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4020BF	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD4020BF3A	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD4020BNSR	ACTIVE	SO	NS	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4020BPW	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4020BPWR	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4024BE	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4024BF	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
CD4024BF3A	ACTIVE	CDIP	J	14	1%	None	Call TI	Level-NC-NC-NC
CD4024BM	ACTIVE	SOIC	D	14	50	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4024BM96	ACTIVE	SOIC	D	14	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4024BMT	ACTIVE	SOIC	D	14	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4024BNSR	ACTIVE	SO	NS	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4024BPW	ACTIVE	TSSOP	PW	14	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4024BPWR	ACTIVE	TSSOP	PW	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4040BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4040BF	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD4040BF3A	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD4040BM	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4040BM96	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4040BNSR	ACTIVE	SO	NS	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD4040BPW	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4040BPWR	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
JM38510/05653BEA	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
JM38510/05655BCA	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC

(1) The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs. **LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.



#### PACKAGE OPTION ADDENDUM

28-Feb-2005

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

**Pb-Free** (RoHS): Ti's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

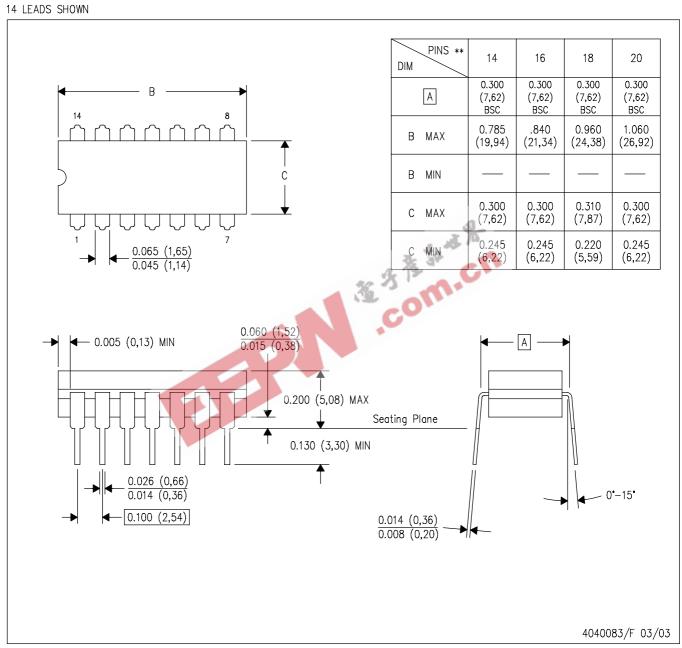
Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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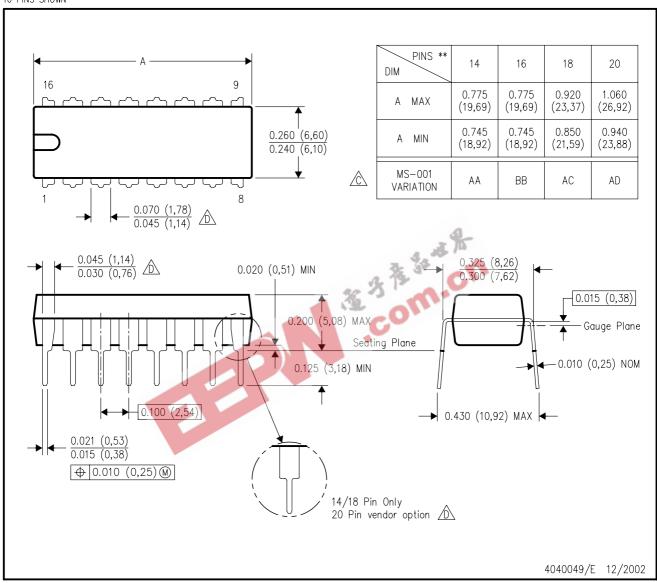


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

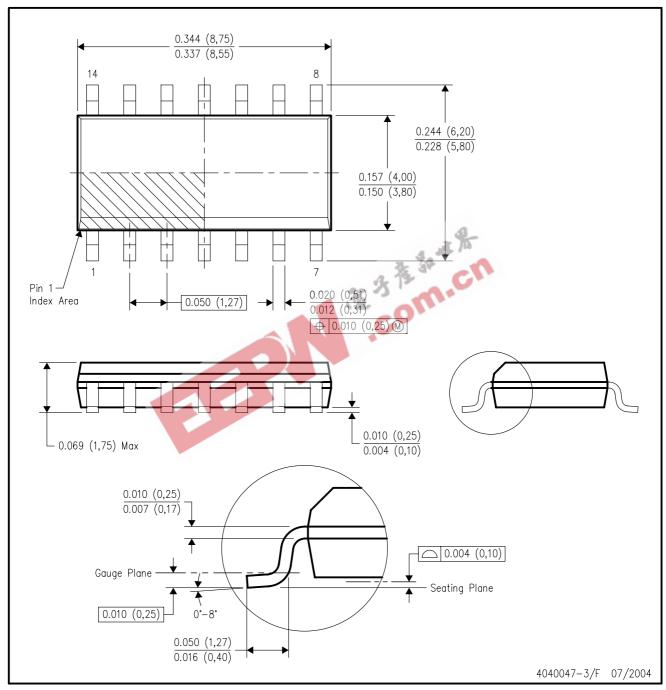


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



# D (R-PDSO-G14)

# PLASTIC SMALL-OUTLINE PACKAGE

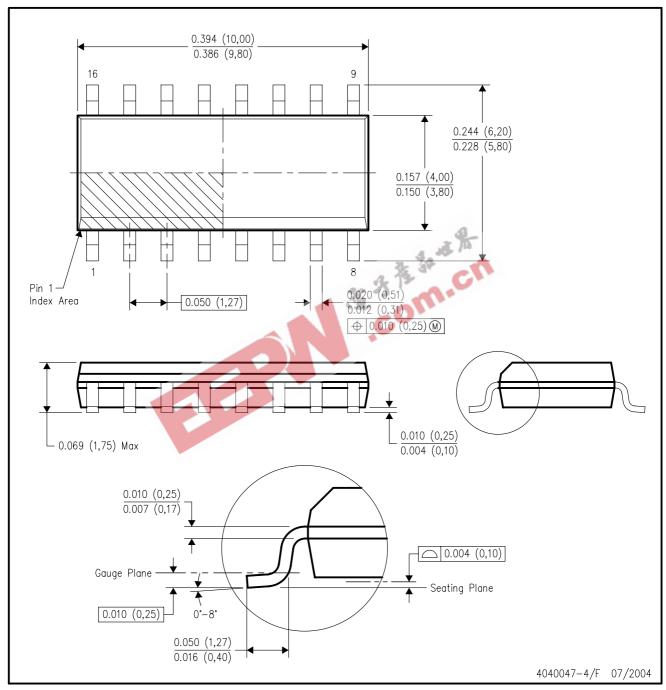


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AB.



# D (R-PDSO-G16)

# PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.

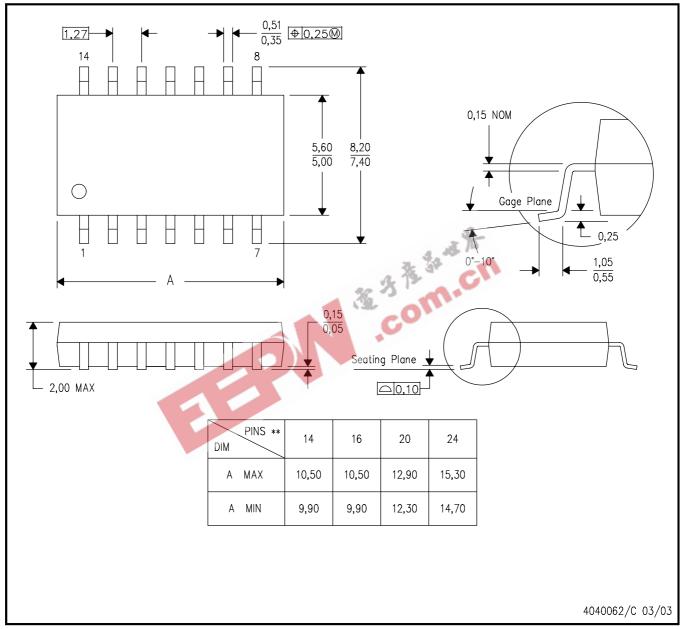


#### **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

#### 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



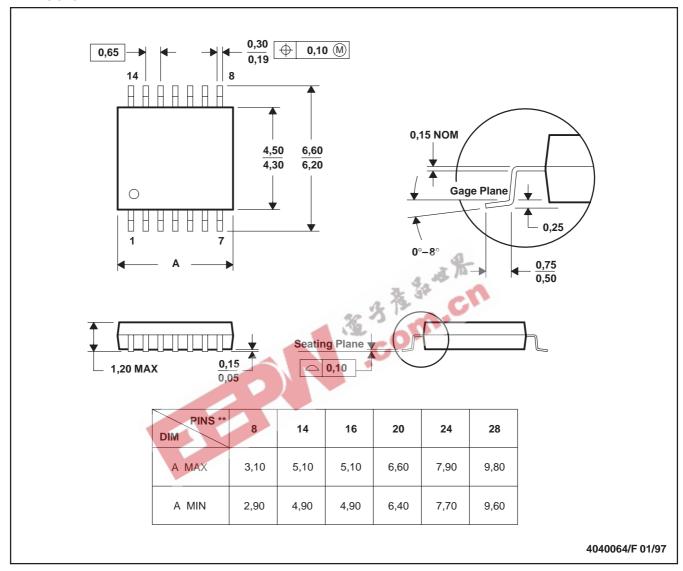
- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



#### PW (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE PACKAGE

#### 14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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